# TEXAS Instruments

Data sheet acquired from Harris Semiconductor SCHS149

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#### Features

- Buffered Inputs and Outputs
- Typical Propagation Delay: 13ns at  $V_{CC} = 5V$ ,  $C_L = 15pF$ ,  $T_A = 25^{\circ}C$
- Fanout (Over Temperature Range)
  - Standard Outputs..... 10 LSTTL Loads
  - Bus Driver Outputs ..... 15 LSTTL Loads
- Wide Operating Temperature Range ... -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
  - 2V to 6V Operation
  - High Noise Immunity: N<sub>IL</sub> = 30%, N<sub>IH</sub> = 30% of V<sub>CC</sub> at V<sub>CC</sub> = 5V
- HCT Types
  - 4.5V to 5.5V Operation
  - Direct LSTTL Input Logic Compatibility, V<sub>IL</sub>= 0.8V (Max), V<sub>IH</sub> = 2V (Min)
  - CMOS Input Compatibility, II  $\leq$  1µA at VOL, VOH

# *CD74HC147, CD74HCT147*

High Speed CMOS Logic 10-to-4 Line Priority Encoder

## Description

The Harris CD74HC147 and CD74HCT147 are high speed silicon-gate CMOS devices and are pin-compatible with low power Schottky TTL (LSTTL).

The CD74HC147 and CD74HCT147 9-input priority encoders accept data from nine active LOW inputs ( $I_1$  to  $I_9$ ) and provide binary representation on the four active LOW inputs ( $\overline{Y0}$  to  $\overline{Y3}$ ). A priority is assigned to each input so that when two or more inputs are simultaneously active, the input with the highest priority is represented on the output, with input line  $I_9$  having the highest priority.

These devices provide the 10-line to 4-line priority encoding function by use of the implied decimal "zero". The "zero" is encoded when all nine data inputs are HIGH, forcing all four outputs HIGH.

## **Ordering Information**

PART NUMBER	TEMP. RANGE ( <sup>o</sup> C)	PACKAGE	PKG. NO.
CD74HC147E	-55 to 125	16 Ld PDIP	E16.3
CD74HCT147E	-55 to 125	16 Ld PDIP	E16.3
CD74HC147M	-55 to 125	16 Ld SOIC	M16.15
CD74HCT147M	-55 to 125	16 Ld SOIC	M16.15

NOTES:

- 1. When ordering, use the entire part number. Add the suffix 96 to obtain the variant in the tape and reel.
- 2. Wafer or die for this part number is available which meets all electrical specifications. Please contact your local sales office or Harris customer service for ordering information.

#### Pinout



CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures. Copyright © Harris Corporation 1997

# Functional Diagram



#### TRUTH TABLE

				OUTI	PUTS							
ĪĪ	12	13	14	15	16	17	18	19	<u>¥3</u>	<u>Y2</u>	Υ <u>1</u>	YO
н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
Х	Х	Х	Х	Х	Х	Х	Х	L	L	Н	Н	L
Х	Х	Х	Х	Х	Х	Х	L	Н	L	Н	Н	Н
Х	Х	Х	Х	Х	Х	L	Н	Н	Н	L	L	L
Х	Х	Х	Х	Х	L	Н	Н	Н	Н	L	L	Н
Х	Х	Х	Х	L	Н	Н	Н	Н	Н	L	Н	L
Х	Х	Х	L	Н	Н	Н	Н	Н	Н	L	Н	Н
х	Х	L	н	Н	Н	Н	Н	Н	Н	Н	L	L
х	L	Н	н	Н	Н	Н	Н	Н	Н	Н	L	Н
L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L

NOTE: H = High Logic Level, L = Low Logic Level, X = Don't Care

#### **Absolute Maximum Ratings**

DC Supply Voltage, V_CC $\ldots$ -0.5V to 7V
DC Input Diode Current, I <sub>IK</sub>
For $V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$ ±20mA
DC Output Diode Current, IOK
For $V_0 < -0.5V$ or $V_0 > V_{CC} + 0.5V$
DC Output Source or Sink Current per Output Pin, IO
For $V_{O} > -0.5V$ or $V_{O} < V_{CC} + 0.5V$
DC V <sub>CC</sub> or Ground Current, I <sub>CC or</sub> I <sub>GND</sub> ±50mA

#### **Operating Conditions**

Temperature Range (T <sub>A</sub> )55°C to 125°C
Supply Voltage Range, V <sub>CC</sub>
HC Types
HCT Types4.5V to 5.5V
DC Input or Output Voltage, V <sub>I</sub> , V <sub>O</sub> 0V to V <sub>CC</sub>
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

#### **Thermal Information**

Thermal Resistance (Typical, Note 3)	θ <sub>JA</sub> ( <sup>o</sup> C/W)
PDIP Package	90
SOIC Package	160
Maximum Junction Temperature	150 <sup>0</sup> C
Maximum Storage Temperature Range6	5 <sup>o</sup> C to 150 <sup>o</sup> C
Maximum Lead Temperature (Soldering 10s)	
(SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

3.  $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.

#### **DC Electrical Specifications**

		TE: CONDI	-	v <sub>cc</sub>		25 <sup>0</sup> C		-40 <sup>0</sup> C T	O 85°C	-55 <sup>0</sup> C T	O 125 <sup>0</sup> C	
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES					_	_	_					-
High Level Input V <sub>IH</sub> Voltage	VIH	-	-	2	1.5	-	-	1.5	-	1.5	-	V
			4.5	3.15	-	-	3.15	-	3.15	-	V	
				6	4.2	-	-	4.2	-	4.2	-	V
Low Level Input	VIL	-	-	2	-	-	0.5	-	0.5	-	0.5	V
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V
				6	-	-	1.8	-	1.8	-	1.8	V
High Level Output V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	2	1.9	-	-	1.9	-	1.9	-	V	
Voltage CMOS Loads			-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
CIVIOS LOAUS			-0.02	6	5.9	-	-	5.9	-	5.9	-	V
High Level Output	1		-	-	-	-	-	-	-	-	-	V
Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
			-5.2	6	5.48	-	-	5.34	-	5.2	-	V
Low Level Output	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	2	-	-	0.1	-	0.1	-	0.1	V
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
CINOS LOAUS			0.02	6	-	-	0.1	-	0.1	-	0.1	V
Low Level Output			-	-	-	-	-	-	-	-	-	V
Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
TTE LOADS			5.2	6	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V <sub>CC</sub> or GND	-	6	-	-	±0.1	-	±1	-	±1	μA
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	6	-	-	8	-	80	-	160	μA

#### DC Electrical Specifications (Continued)

		TES CONDI	-	V <sub>CC</sub>		25 <sup>0</sup> C		-40°C T	O 85ºC	-55°C T	O 125ºC	
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)			TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HCT TYPES												
High Level Input Voltage	V <sub>IH</sub>	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V
Low Level Input Voltage	VIL	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
Low Level Output Voltage CMOS Loads	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V <sub>CC</sub> and GND	0	5.5	-		±0.1	-	±1	-	±1	μA
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	5.5	-	-	8	-	80	-	160	μA
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI <sub>CC</sub>	V <sub>CC</sub> -2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	μA

NOTE: For dual-supply systems theoretical worst case ( $V_I = 2.4V$ ,  $V_{CC} = 5.5V$ ) specification is 1.8mA.

### **HCT Input Loading Table**

INPUT	UNIT LOADS
$\overline{I}_{\overline{1}}, \overline{I}_{\overline{2}}, \overline{I}_{\overline{3}}, \overline{I}_{\overline{6}}, \overline{I}_{\overline{7}}$	1.1
$\overline{I}_{\overline{4}}, \overline{I}_{\overline{5}}, \overline{I}_{\overline{8}}, \overline{I}_{\overline{9}}$	1.5

NOTE: Unit Load is  $\Delta I_{CC}$  limit specified in DC Electrical Table, e.g., 360µA max at 25°C.

### Switching Specifications Input $t_r$ , $t_f = 6ns$

		TEST		25 <sup>0</sup> C			-40°C TO 85°C		-55°C TO 125°C			
PARAMETER	ARAMETER SYMBOL		V <sub>CC</sub> (V)	MIN	ТҮР	MAX	MIN	MAX	MIN	MAX	UNITS	
HC TYPES												
Propagation Delay,	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	160	-	200	-	240	ns	
Input to Output (Figure 1)			4.5	-	-	32	-	40	-	48	ns	
			5	-	13	-	-	-	-	-	ns	
			6	-	-	27	-	34	-	41	ns	
Transition Times	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	2	-	-	75	-	95	-	110	ns	
(Figure 1)			4.5	-	-	15	-	19	-	22	ns	
			6	-	-	13	-	16	-	19	ns	
Input Capacitance	C <sub>IN</sub>	-	-	-	-	10	-	10	-	10	pF	

Switching Specifications	Input t <sub>r</sub> , t <sub>f</sub> = 6ns	(Continued)
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		TEST		25 <sup>0</sup> C			-40 <sup>0</sup> C T	O 85°C	-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS	V <sub>CC</sub> (V)	MIN	IN TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Power Dissipation Capaci- tance (Notes 4, 5)	C <sub>PD</sub>	-	5	-	32	-	-	-	-	-	pF
HCT TYPES											
Propagation Delay,	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	35	-	44	-	53	ns
Input to Output (Figure 2)			5	-	14	-	-	-	-	-	ns
Transition Times (Figure 2)	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	15	-	19	-	22	ns
Input Capacitance	C <sub>IN</sub>	-	-	-	-	10	-	10	-	10	pF
Power Dissipation Capaci- tance (Notes 4, 5)	C <sub>PD</sub>	-	5	-	42	-	-	-	-	-	pF

NOTES:

4.  $C_{PD}$  is used to determine the dynamic power consumption, per gate.

5.  $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$  where  $f_i =$  Input Frequency,  $C_L =$  Output Load Capacitance,  $V_{CC} =$  Supply Voltage.

### Test Circuits and Waveforms



FIGURE 6. HC AND HCU TRANSITION TIMES AND PROPAGA-TION DELAY TIMES, COMBINATION LOGIC



FIGURE 7. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

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